

# MU0520X LDMOS TRANSISTOR

Document Number: MU0520X  
Preliminary Datasheet V1.0

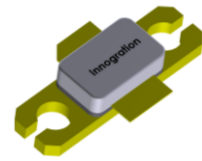
## 200W, HF-200MHz 28V High Power RF LDMOS

### Description

The MU0520X is a 200W single ended 28V LDMOS, highly rugged, unmatched for any applications within HF-200MHz

It supports CW, and pulsed and any modulated signal at either saturated or linear application.

MU0520X



- Typical Performance (On Innogrator multiple fixtures with device soldered):

$V_{DD} = 28$  Volts,  $I_{DQ} = 150$  mA, CW.

Frequency	Pin (dBm)	Gp (dB)	$P_{OUT}$ (W)	$\eta_D$ (%)	2 <sup>nd</sup> (dB)	3 <sup>rd</sup> (dB)
30MHz	28	25	200	78	-26	-39
40.68MHz	33	20	203	81	-28	-41

### Features

- High Efficiency and Linear Gain Operations
- Integrated ESD Protection
- Excellent thermal stability, low HCI drift
- Large Positive and Negative Gate/Source Voltage Range for Improved Class C Operation
- Pb-free, RoHS-compliant

### Suitable Applications

- 2-30MHz (HF or Short wave communication)
- 30-88MHz (Ground communication)
- 54-88MHz (TV VHF I)
- 88-108MHz (FM)
- 118 -140MHz (Avionics)
- 136-174MHz (Commercial ground communication)
- 160-230MHz (TV VHF III)

Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain--Source Voltage	$V_{DS}$	+95	Vdc
Gate--Source Voltage	$V_{GS}$	-10 to +10	Vdc
Operating Voltage	$V_{DD}$	+36	Vdc
Storage Temperature Range	$T_{stg}$	-65 to +150	°C
Case Operating Temperature	$T_c$	+150	°C
Operating Junction Temperature	$T_J$	+225	°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value	Unit
Thermal Resistance, Junction to Case $T_C = 85^\circ\text{C}$ , $T_J = 200^\circ\text{C}$ , DC test	$R_{\theta JC}$	0.55	°C/W

Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22--A114)	Class 2

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**Table 4. Electrical Characteristics** (TA = 25 °C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
<b>DC Characteristics</b>					
Drain-Source Voltage V <sub>GS</sub> =0, I <sub>DS</sub> =1.0mA	V <sub>(BR)DSS</sub>	95	—		V
Zero Gate Voltage Drain Leakage Current (V <sub>DS</sub> = 75V, V <sub>GS</sub> = 0 V)	I <sub>DSS</sub>	—	—	1	μA
Zero Gate Voltage Drain Leakage Current (V <sub>DS</sub> = 28 V, V <sub>GS</sub> = 0 V)	I <sub>DSS</sub>	—	—	1	μA
Gate--Source Leakage Current (V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 0 V)	I <sub>GSS</sub>	—	—	1	μA
Gate Threshold Voltage (V <sub>DS</sub> = 28V, I <sub>D</sub> = 400 μA)	V <sub>GS(th)</sub>	—	2.2	—	V
Gate Quiescent Voltage (V <sub>DD</sub> = 28 V, I <sub>D</sub> = 150 mA, Measured in Functional Test)	V <sub>GS(Q)</sub>	—	3.05	—	V
Common Source Input Capacitance (V <sub>GS</sub> = 0V, V <sub>DS</sub> =28 V, f = 1 MHz)	C <sub>ISS</sub>		187		pF
Common Source Output Capacitance (V <sub>GS</sub> = 0V, V <sub>DS</sub> =28 V, f = 1 MHz)	C <sub>OSS</sub>		79		pF
Common Source Feedback Capacitance (V <sub>GS</sub> = 0V, V <sub>DS</sub> =28 V, f = 1 MHz)	C <sub>RSS</sub>		4.6		pF

**Functional Tests** (In Demo Test Fixture, 50 ohm system) V<sub>DD</sub> = 28 Vdc, I<sub>DQ</sub> = 150mA, f = 150 MHz, Pin=2W, CW Signal Measurements.

Power Gain	G <sub>p</sub>	—	20	—	dB
Drain Efficiency@Pout	η <sub>D</sub>	—	80	—	%
Output Power	P <sub>out</sub>	—	200	—	W
Input Return Loss	IRL	—	-7	—	dB

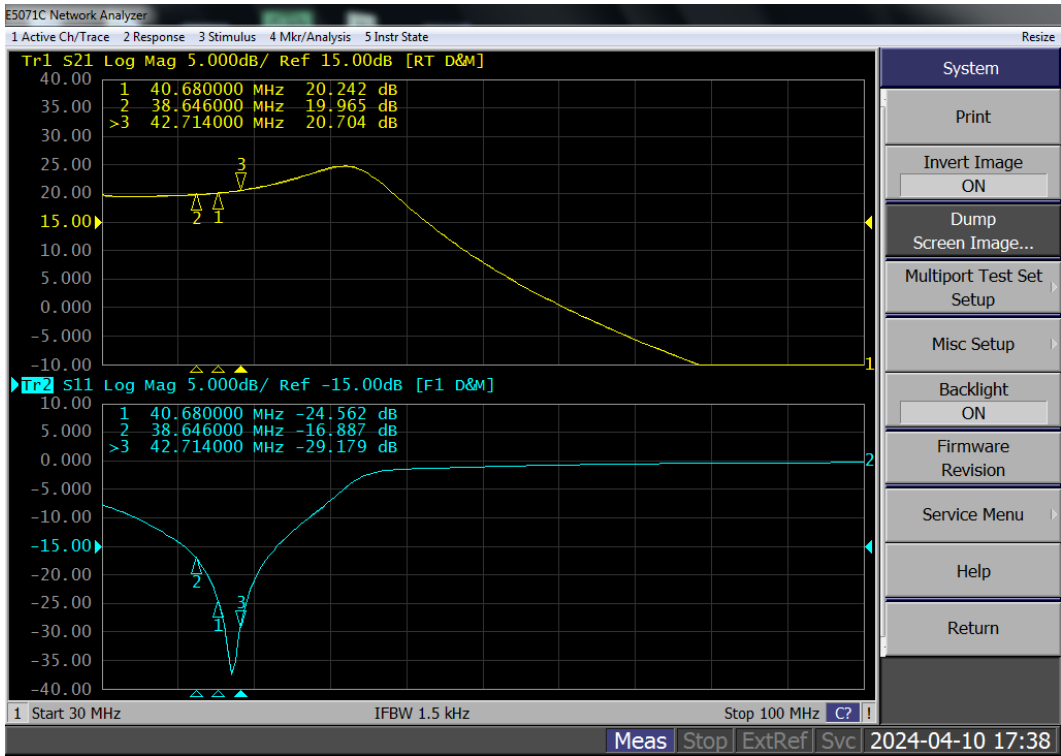
**Load Mismatch (In Innogration Test Fixture, 50 ohm system):** V<sub>DD</sub> = 28 Vdc, I<sub>DQ</sub> = 150 mA, f = 150 MHz

VSWR 20:1 at 200W pulse CW Output Power	No Device Degradation
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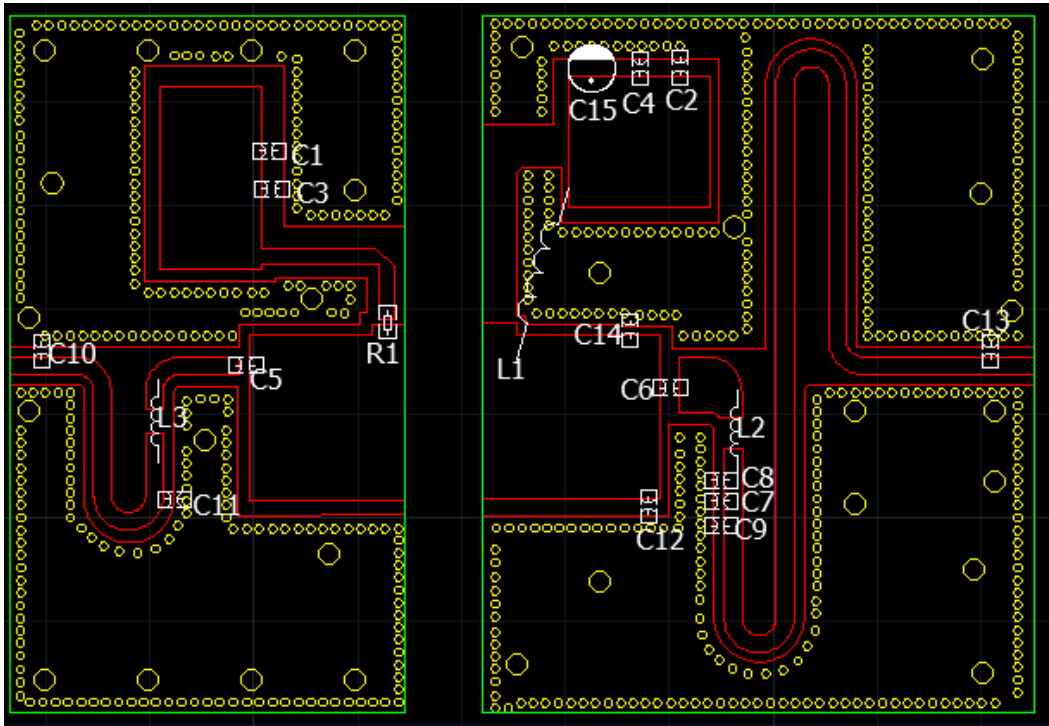
40.68MHz

TYPICAL CHARACTERISTICS

Figure 1: Network analyzer output S11/221



Reference Circuit of Test Fixture Assembly Diagram (PCB file upon request)



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Table 1. Test Circuit Component Designations and Values (40.68MHz)

Component	Description	Suggestion
C1,C2	10uF	10uF/100V
C3~C6	10nF	10nF/100V
C7,C8	150pF	MQ101111
C9	39pF	MQ101111
C10	120pF	MQ101111
C11	47pF	MQ101111
C12	18pF	MQ101111
C13	12pF	MQ101111
C14	200pF	MQ101111
C15	470uF/63V	Electrolytic Capacitor
R1	10 $\Omega$	Chip Resistor
L1	1.5mm/5mm, 8 turns	
L2	1.5mm/5mm, 4 turns	
L3	1.5mm/5mm, 6 turns	
PCB	30Mil Rogers4350	

Package Outline

Flanged ceramic package; 2 leads

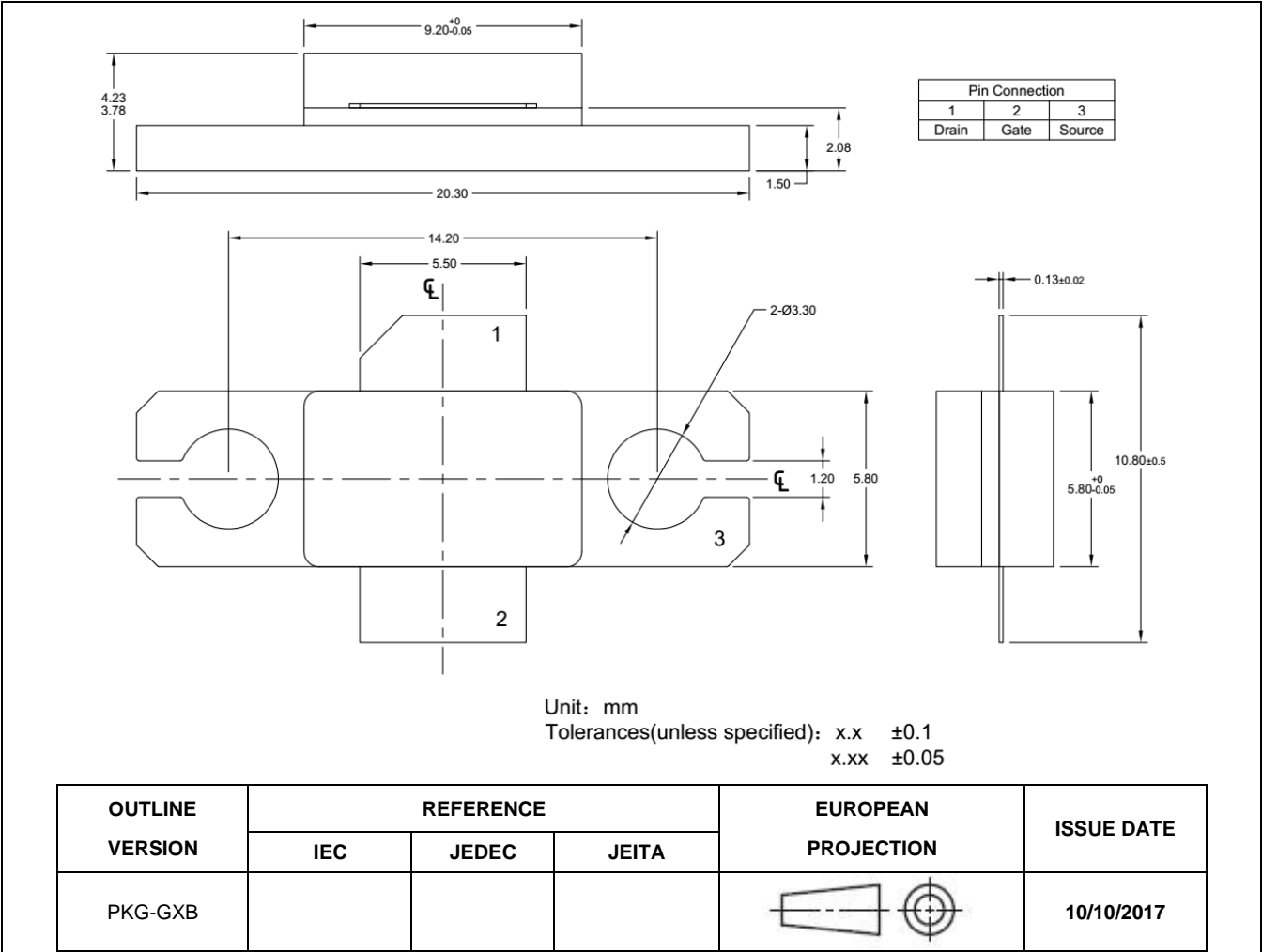


Figure 1. Package Outline PKG-G2E

## Revision history

Table 5. Document revision history

Date	Revision	Datasheet Status
2025/4/23	Rev 1.0	Preliminary datasheet

Application data based on TC-24-22/SJJ-25-09

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